

MOSFET - N-Channel, Shielded Gate, POWERTRENCH®

100 V, 24 m Ω , 22 A

FDMC86102LZ

Description

This N-Channel logic Level MOSFETs are produced using onsemi's advanced POWERTRENCH process that incorporates Shielded Gate technology. This process has been optimized for the on-state resistance and yet maintain superior switching performance. G-S zener has been added to enhance ESD voltage level.

Features

- Shielded Gate MOSFET Technology
- Max $R_{DS(on)} = 24 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 6.5 \text{ A}$
- Max $R_{DS(on)} = 35 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 5.5 \text{ A}$
- HBM ESD Protection Level > 6 kV Typical (Note 4)
- 100% UIL Tested
- RoHS Compliant

Applications

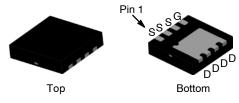
• DC-DC Switching

MAXIMUM RATINGS (T_A = 25°C unless otherwise specified)

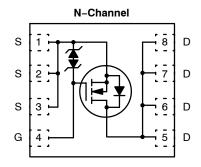
Symbol	Parameter	Ratings	Unit
V _{DS}	Drain-to-Source Voltage	100	٧
V _{GS}	Gate-to-Source Voltage	±20	V
I _D	Drain Current - Continuous T _C = 25°C	22	Α
	– Continuous $T_A = 25^{\circ}C$ (Note 1a)	7	
	- Pulsed	30	
E _{AS}	Single Pulse Avalanche Energy (Note 3)	84	mJ
P _D	Power Dissipation $T_C = 25^{\circ}C$	41	W
	Power Dissipation $T_A = 25^{\circ}C$ (Note 1a)	2.3	
T _J , T _{STG}	Operating and Storage Junction Temperature Range	-55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1



WDFN8 MPL CASE 511DH



MARKING DIAGRAM

FDMC 86102Z AKKXY

FDMC86102Z = Specific Device Code
A = Assembly Plant Code
KK = Lot Run Traceability Code
XY = Numeric Date Code

ORDERING INFORMATION

Device	Package	Shipping [†]
FDMC86102LZ	WDFN8 (Pb-Free, Halide Free)	3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	3	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	53	

ELECTRICAL CHARACTERISTICS (T _J = 25°C unless otherwise noted)						
Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHARA	CTERISTICS					
BV _{DSS}	Drain-to-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	100	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25°C	-	71	-	mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 80 V, V _{GS} = 0 V	-	-	1	μΑ
I _{GSS}	Gate-to-Source Leakage Current	V _{GS} = ±20 V, V _{DS} = 0 V	-	-	±10	μΑ
ON CHARAC	CTERISTICS					
V _{GS(th)}	Gate-to-Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1.0	1.6	2.2	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate-to-Source Threshold Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25°C	-	-6	-	mV/°C
R _{DS(on)}	Static Drain-to-Source On Resistance	V _{GS} = 10 V, I _D = 6.5 A	-	19	24	mΩ
		V _{GS} = 4.5 V, I _D = 5.5 A	-	25	35	1
		V _{GS} = 10 V, I _D = 6.5 A, T _J = 125°C	-	31	40	1
9FS	Forward Transconductance	V _{DS} = 5 V, I _D = 6.5 A	-	24	-	S
DYNAMIC C	HARACTERISTICS					•
C _{iss}	Input Capacitance	V _{DS} = 50 V, V _{GS} = 0 V, f = 1 MHz	-	969	1290	pF
C _{oss}	Output Capacitance		-	181	240	pF
C _{rss}	Reverse Transfer Capacitance		-	9	15	pF
R _g	Gate Resistance		-	0.4	-	Ω
SWITCHING	CHARACTERISTICS					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 50 \text{ V}, I_D = 6.5 \text{ A}, V_{GS} = 10 \text{ V},$	_	7.1	15	ns
t _r	Rise Time	$R_{GEN} = 6 \Omega$	-	2.3	10	1
t _{d(off)}	Turn-Off Delay Time		-	19	35	1
t _f	Fall Time		-	2.5	10	1
Q _{g(tot)}	Total Gate Charge	$V_{GS} = 0 \text{ V to } 10 \text{ V}, V_{DD} = 50 \text{ V}, I_D = 6.5 \text{ A}$	-	15.3	22	nC
Q _{g(tot)}	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V}, V_{DD} = 50 \text{ V}, I_D = 6.5 \text{ A}$	-	7.6	11	1
Q _{gs}	Gate-to-Source Charge	V _{DD} = 50 V, I _D = 6.5 A	-	2.4	-	1
Q _{gd}	Gate-to-Drain "Miller" Charge	V _{DD} = 50 V, I _D = 6.5 A	-	2.5	-	1

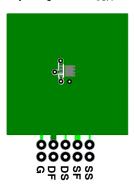
ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS						
V _{SD}	Source-to-Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 6.5 A (Note 2)	-	0.80	1.3	V
		V _{GS} = 0 V, I _S = 2 A (Note 2)	-	0.72	1.2	V
t _{rr}	Reverse Recovery Time	I _F = 6.5 A, di/dt = 100 A/μs	_	37	59	ns
Q _{rr}	Reverse Recovery Charge		1	27	43	nC

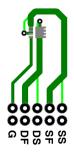
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 \times 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a) 53°C/W when mounted on a 1 in² pad of 2 oz copper



b) 125°C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%. 3. Starting T_J = 25°C; N-ch: L = 1 mH, I_{AS} = 13 A, V_{DD} = 90 V, V_{GS} = 10 V. 4. The diode connected between gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

TYPICAL CHARACTERISTICS

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$

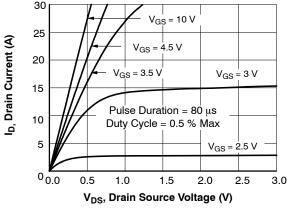


Figure 1. On-Region Characteristics

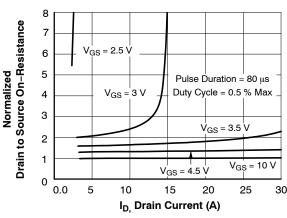


Figure 2. Normalized On–Resistance vs.
Drain Current and Gate Voltage

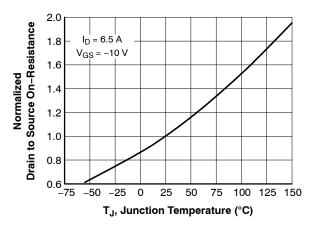


Figure 3. Normalized On–Resistance vs. Junction Temperature

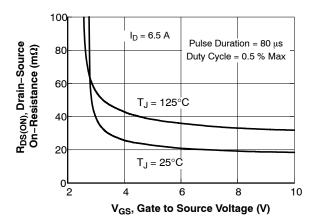


Figure 4. On-Resistance vs. Gate-to-Source Voltage

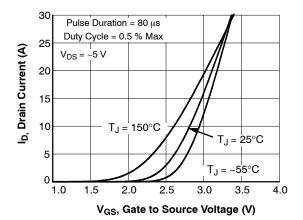
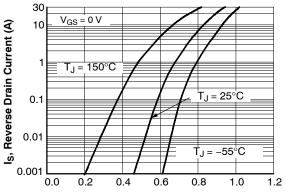


Figure 5. Transfer Characteristics



V_{SD}, Body Diode Forward Voltage (V)

Figure 6. Source-to-Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS (continued)

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$

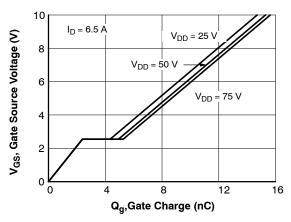


Figure 7. Gate Charge Characteristics

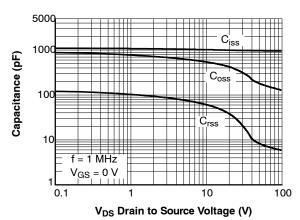


Figure 8. Capacitance vs Drain-to-Source Voltage

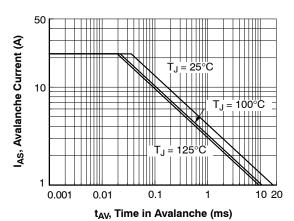


Figure 9. Unclamped Inductive Switching Capability

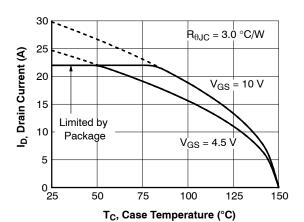


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

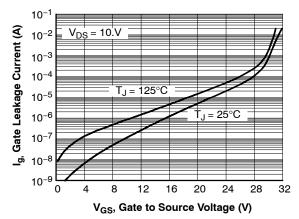


Figure 11. Gate Leakage Current vs. Gate-to-Source Voltage

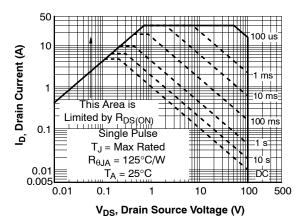


Figure 12. Forward Bias Safe
Operating Area

TYPICAL CHARACTERISTICS (continued)

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$

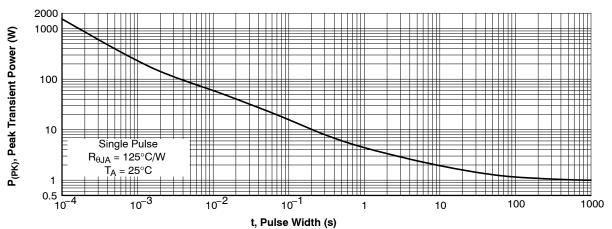


Figure 13. Single Pulse Maximum Power Dissipation

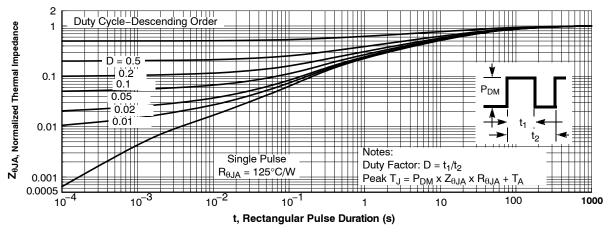


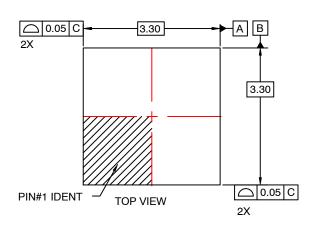
Figure 14. Junction-to-Ambient Transient Thermal Response

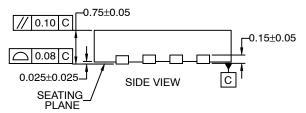
POWERTRENCH is a registered trademark of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries.

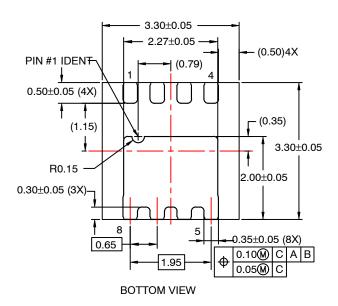


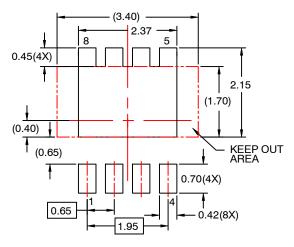
WDFN8 3.3x3.3, 0.65P CASE 511DH **ISSUE O**

DATE 31 JUL 2016









RECOMMENDED LAND PATTERN

NOTES:

- A. DOES NOT CONFORM TO JEDEC **REGISTRATION MO-229**
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.

DOCUMENT NUMBER:	98AON13625G	Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	WDFN8 3.3X3.3, 0.65P	•	PAGE 1 OF 1	

ON Semiconductor and unare trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMI., and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using **onsemi** products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by **onsemi**. "Typical" parameters which may be provided in **onsemi** data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. **onsemi** does not convey any license under any of its intellectual property rights nor the rights of others. **onsemi** products are not designed, intended, or authorized for use as a critical component in life support systems. or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use **onsemi** products for any such unintended or unauthorized application, Buyer shall indemnify and hold **onsemi** and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that **onsemi** was negligent regarding the design or manufacture of the part. **onsemi** is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

ADDITIONAL INFORMATION

TECHNICAL PUBLICATIONS:

 $\textbf{Technical Library:} \ \underline{www.onsemi.com/design/resources/technical-documentation}$

onsemi Website: www.onsemi.com

ONLINE SUPPORT: www.onsemi.com/support

For additional information, please contact your local Sales Representative at

www.onsemi.com/support/sales